



Reduction in V_f (max) and Associated Parameters (Comments 345-360)

Bill Simms

NVIDIA

Supporters

- Piers Dawe, NVIDIA
- Mike Dudek, Marvell
- Ali Ghiasi, Ghiasi Quantum
- Hossein Shakiba, Huawei

Reduction in Vf Max and Associated Parameters

Purpose

- Propose reduction of Vf(max) from 600mV to 500mV:
 - Associated Differential peak-to-peak values 1.2V to 1.0V
 - Associated COM parameters Av, Ane, Afe to appropriate scaled values for impedance mismatch
- Why now
 - Reduction in XTALK improves link performance in COM
 - Potential system power and radiated noise savings
 - Silicon process nodes are becoming less tolerant of high voltages
 - Removal of attenuators and limiters reduces noise in the receive chain

Proposed Changes to Draft

- In Sections:
 - 178. Physical Medium Dependent (PMD) sublayer and medium, type 200GBASE-KR1, 400GBASE-KR2, 800GBASE-KR4, and 1.6TBASE-KR8
 - 179. Physical Medium Dependent (PMD) sublayer and medium, type 200GBASE-CR1, 400GBASE-CR2, 800GBASE-CR4, 1.6TBASE-CR8
 - Annex 176C: Chip-to-chip Attachment Unit Interfaces 200GAUI-1 C2C, 400GAUI-2 C2C, 800GAUI-4 C2C, and 1.6TAUI-8 C2C
 - Annex 176D: Chip-to-module Attachment Unit Interfaces 200GAUI-1 C2M, 400GAUI-2 C2M, 800GAUI-4 C2M, and 1.6TAUI-8 C2M
- Comments # 356
 - Reduce Transmitter steady-state voltage V_f (max) to 0.5V (down from 0.6V)
- Comments #354, 348
 - Reduce Transmitter steady-state voltage V_f range 0.4V to 0.5V (down from 0.4 to 0.6V)
- Comments #352, 359, 346, 351
 - Reduce A_{ne} from 0.578V to 0.482V (0.481) to be consistent with V_f (max) of 0.5V
- Comments #353, 355, 345, 347,
 - Reduce Differential pk-pk voltage (max) to 1.0V to be consistent with V_f (max) of 0.5V
- Comments #357, 358, 360, 349, 350,
 - Reduce Amplitude tolerance to 1.0V (down from 1.2V)

Impact of changes

- Improvements to receiver designs
 - Lowers the dynamic range of the signal seen at the front end
 - Reduces need for an additional limiter or attenuator for low-voltage silicon designs
 - Improves linearity of the system by not stressing the extremes of process voltage
 - May reduce need for RX to request amplitude reduction from remote TX
 - Reduces ESD complexity for low-power designs
 - Improves ENOB and reduces noise translated into RxFFE and DFE/MLSE
- Improvements to transmitter designs
 - Improves TX linearity and lowers probability of clipping
 - Improved P-N wave-shape matching lowers common-mode conversion and radiated emissions
 - Reduced amplitude for all transmitters reduces XTALK for the system

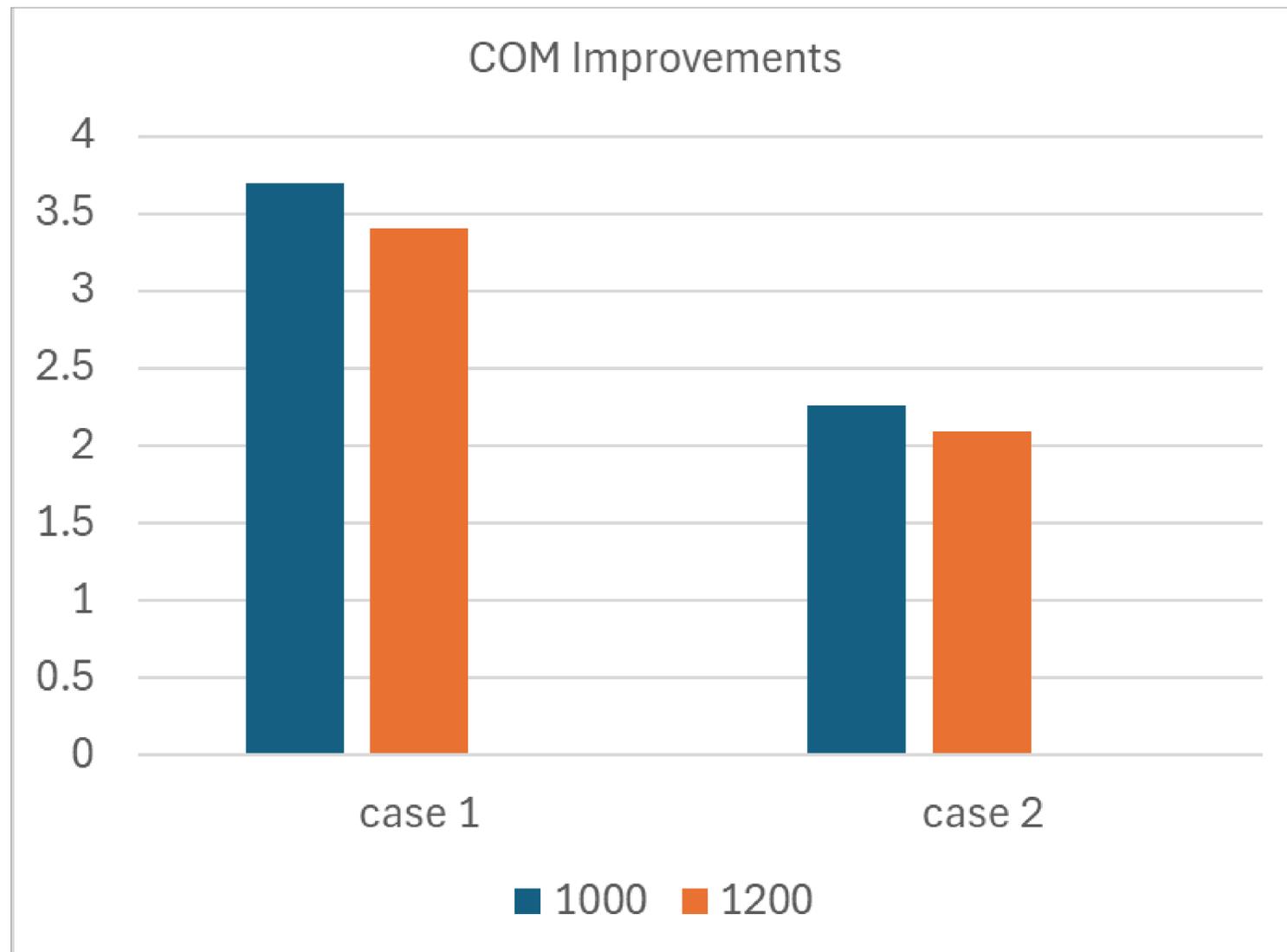
Industry Trend

- Aligns Ethernet with other SERDES standards like PCI Express
 - 5.0 spec all data rates 1200mV Differential peak to peak voltage (max) (2019)
 - 6.01 spec all data rates 1000mV Differential peak to peak voltage (max) (2022)
 - 36dB pad to pad loss in 5.0 and 32dB for 6.0
- Industry recognized that 50% margin on the nominal voltage was problematic
 - Process nodes no longer support higher voltages
 - Reducing the range from 50% to 25% better bounds the solution space and implementations
 - Calibration circuits from decades ago are greatly improved to allow better control and matching

Challenges of 0.6V Vf max support in current silicon

- Silicon process technologies have reduced voltage supplies over the last several node generations
 - Future technology nodes are unlikely to reverse this trend
- Many current RX designs cannot tolerate high TX Differential peak to peak voltage (max) and require use of swing control to request reduction
 - Overdriving the receiver front end can lead to linearity problems which impact accurate PAM4 recovery
 - Failure to respond to swing reduction request can lead to electrical overstress
- In short channel applications, RX will typically reduce Differential peak to peak voltage (max) to save power and reduce crosstalk

COM Simulations for CR



0.3dB and 0.17 dB COM improvements

- Example Case showing improvement of reducing the xtalk terms
- Simulations of marginal passing and marginal failing CR channels (Case 1 vs Case 2)
- Channels run with A_{ne} .6V and then 0.5V mV
- Improvements noted in COM by reducing A_{ne} relative to other parameters
- Further investigation may show additional improvements of other COM parameters
- This example:
 - uses akinwale_3dj_01_2311, 22dB channel vendor X
 - COM4.6

Summary

- Reducing V_f max from 0.6V to 0.5V
 - Reduces complexity of receiver design
 - Enables lower power supply SERDES
 - Enables current and future silicon process nodes
 - Increases compatibility with other SERDES Specifications
 - Reduces system power and noise



Thank You

Backup

Comments

| | Sub-clause | Line # | Comment | Proposed Change |
|-----|------------|--------|---|--|
| 345 | 178.9.2 | 18 | Table 178-6 has the Differential pk-pk voltage (max) Transmit enabled as 1.2V. This should be reduced to 1.0V to be consistent with Vf of 0.500 | Reduce Differential pk-pk voltage (max) to 1.0V when Transmitter enabled |
| 346 | 178.10.1 | 12 | Table 178-13 has Ane set to 0.578V which is consistent with 0.6Vf but should be reduced to 0.482 to match Vf of 0.5V | Reduce Ane to 0.482 |
| 347 | 179.9.4 | 40 | Table 179-7 has the Differential pk-pk voltage (max) Transmit enabled as 1.2V. This should be reduced to 1.0V to be consistent with Vf of 0.500 | Reduce Differential pk-pk voltage (max) to 1.0V when Transmitter enabled |
| 347 | 179.9.4 | 51 | Table 179-7 has Transmitter steady-state voltage, Vf (range) 0.4 to 0.6 V. This range should be reduced to 0.4 to 0.5 to be consistent with Vf of 0.500 | change Transmitter steady-state voltage, Vf (range) to 0.4 to 0.5V |
| 349 | 179.9.5 | 40 | Table 179-10 has the Amplitude tolerance set to 1.2V. This should be reduced to 1.0V to be consistent with Vf reduced to 0.5V | Change Amplitude tolerance to 1.0V |
| 350 | 179.9.5.2 | 4 | Amplitude tolerance set to 1.2V. This should be reduced to 1.0V to be consistent with Vf reduced to 0.5V | Change Amplitude tolerance to 1.0V |
| 351 | 179.11.7.1 | 34 | Table 179-17 has Ane set to 0.578V which is consistent with 0.6Vf but should be reduced to 0.482 to match Vf of 0.5V | Reduce Ane to 0.482 |
| 352 | 176C.5.1 | 9 | Table 176C-7 has Ane set to 0.578V which is consistent with 0.6Vf but should be reduced to 0.482 to match Vf of 0.5V | Reduce Ane to 0.482 |

Backup

comments

| | Sub-clause | Line # | Comment | Proposed Change |
|-----|------------|--------|--|--|
| 353 | 176D.5.3 | 24 | Table 176D-1 has the Differential pk-pk voltage (max) Output enabled as 1.2V. This should be reduced to 1.0V to be consistent with Vf of 0.500 | Reduce Differential pk-pk voltage (max) to 1.0V when Transmitter enabled |
| 354 | 176D.5.3 | 34 | Table 176D-1 has Transmitter steady-state voltage, Vf (range) 0.4 to 0.6 V. This range should be reduced to 0.4 to 0.5 to be consistent with Vf of 0.500 | change Transmitter steady-state voltage, Vf (range) to 0.4 to 0.5V |
| 355 | 176D.5.4 | 19 | Table 176D-2 has the Differential pk-pk voltage (max) Output enabled as 1.2V. This should be reduced to 1.0V to be consistent with Vf of 0.500 | Reduce Differential pk-pk voltage (max) to 1.0V when Transmitter enabled |
| 356 | 176D.5.4 | 31 | Table 176D-2 has Transmitter steady-state voltage, Vf (max) 0.6 V. This should be reduced to 0.5 to be consistent with Vf of 0.500 | change Transmitter steady-state voltage, Vf (range) to 0.4 to 0.5V |
| 357 | 176D.5.5 | 27 | Table 176D-3 has the Amplitude tolerance set to 1.2V. This should be reduced to 1.0V to be consistent with Vf reduced to 0.5V | Change Amplitude tolerance to 1.0V |
| 358 | 176D.5.6 | 17 | Table 176D-4 has the Amplitude tolerance set to 1.2V. This should be reduced to 1.0V to be consistent with Vf reduced to 0.5V | Change Amplitude tolerance to 1.0V |
| 359 | 176D.6.2 | 9 | Table 176D=6 has Ane set to 0.578V which is consistent with 0.6Vf but should be reduced to 0.482 to match Vf of 0.5V | Reduce Ane to 0.482 |
| 360 | 176D.7.11 | 36 | Amplitude tolerance set to 1.2V. This should be reduced to 1.0V to be consistent with Vf reduced to 0.5V | Change Amplitude tolerance to 1.0V |

- **178. Physical Medium Dependent (PMD) sublayer and medium, type 200GBASE-KR1, 400GBASE-KR2, 800GBASE-KR4, and 1.6TBASE-KR8**
- **179. Physical Medium Dependent (PMD) sublayer and medium, type 200GBASE-CR1, 400GBASE-CR2, 800GBASE-CR4, 1.6TBASE-CR8**
- **Annex 176C: Chip-to-chip Attachment Unit Interfaces 200GAUI-1 C2C, 400GAUI-2 C2C, 800GAUI-4 C2C, and 1.6TAUI-8 C2C**
- **Annex 176D: Chip-to-module Attachment Unit Interfaces 200GAUI-1 C2M, 400GAUI-2 C2M, 800GAUI-4 C2M, and 1.6TAUI-8 C2M**